## Notice of References Cited Application/Control No. 10/520,949 Examiner TAE K. KIM Applicant(s)/Patent Under Reexamination FRAZER, MARK Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,546,584 A	08-1996	Lundin et al.	719/315
*	В	US-5,835,904 A	11-1998	Vicik et al.	1/1
*	С	US-6,273,622 B1	08-2001	Ben-David, Ido	709/230
*	D	US-2001/0018711 A1	08-2001	Morris, Donal	709/229
*	Е	US-2001/0032254 A1	10-2001	HAWKINS, JEFFREY C.	709/219
*	F	US-6,345,301 B1	02-2002	Burns et al.	709/230
*	G	US-6,374,299 B1	04-2002	Ford et al.	709/227
*	Ι	US-6,480,507 B1	11-2002	Mercer et al.	370/469
*	ı	US-6,546,425 B1	04-2003	Hanson et al.	709/227
*	7	US-7,143,131 B1	11-2006	Soles et al.	709/203
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.